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# HAF2002

Silicon N Channel MOS FET Series Power Switching



ADE-208-503 A (Z) 2nd. Edition October 1997

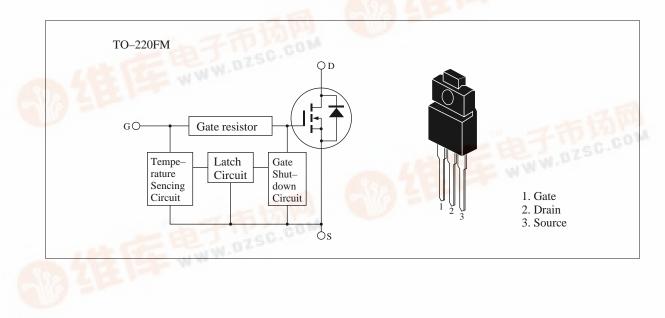
#### Features

This FET has the over temperature shut-down capability sensing to the junction temperature.

This FET has the built-in over temperature shut-down circuit in the gate area. And this circuit operation to shut-down the gate voltage in case of high junction temperature like applying over power consumption, over current etc.

- Logic level operation (4 to 6 V Gate drive)
- High endurance capability against to the short circuit
- Built-in the over temperature shut-down circuit
- Latch type shut–down operation (Need 0 voltage recovery)

#### Outline





# **Absolute Maximum Ratings** (Ta = $25^{\circ}$ C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V <sub>DSS</sub>	60	V	
Gate to source voltage	V <sub>GSS</sub>	16	V	
Gate to source voltage	V <sub>GSS</sub>	-2.8	V	
Drain current	I <sub>D</sub>	20	А	
Drain peak current	Note1 D(pulse)	40	А	
Body-drain diode reverse drain current	I <sub>DR</sub>	20	А	
Channel dissipation	Pch Note2	30	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Note: 1.  $PW \le 10\mu s$ , duty cycle  $\le 1 \%$ 

2. Value at Ta =  $25^{\circ}C$ 

### **Typical Operation Characteristics**

Item	Symbol	Min	Тур	Мах	Unit	Test Conditions
Input voltage	V <sub>IH</sub>	3.5			V	
	V <sub>IL</sub>	_		1.2	V	
Input current	I <sub>IH1</sub>	_		100	μA	Vi = 8V, V <sub>DS</sub> = 0
(Gate non shut down)	I <sub>IH2</sub>	_		50	μA	$Vi = 3.5V, V_{DS} = 0$
	I <sub>IL</sub>	_		1	μA	Vi = 1.2V, V <sub>DS</sub> = 0
Input current	I <sub>IH(sd)1</sub>	—	0.8	_	mA	Vi = 8V, V <sub>DS</sub> = 0
(Gate shut down)	I <sub>IH(sd)2</sub>	_	0.35		mA	$Vi = 3.5V, V_{DS} = 0$
Shut down temperature	$T_{sd}$	_	175		°C	Channel temperature
Gate operation voltage	V <sub>op</sub>	3.5		13	V	

### **Electrical Characteristics** (Ta = 25°C)

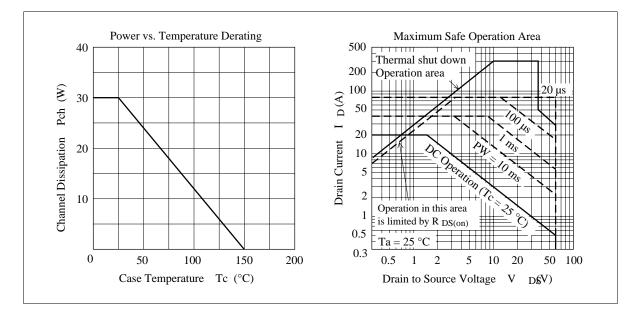
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain current	I <sub>D1</sub>	10	_	_	А	$V_{GS} = 3.5V, V_{DS} = 2V$
Drain current	I <sub>D2</sub>	_		10	mA	$V_{GS} = 1.2V, V_{DS} = 2V$
Drain to source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	60	_	—	V	$I_{\rm D} = 10 {\rm mA}, V_{\rm GS} = 0$
Gate to source breakdown voltage	$V_{(\text{BR})\text{GSS}}$	16	—	_	V	$I_{g} = 100 \mu A, V_{DS} = 0$
Gate to source breakdown voltage	$V_{(\text{BR})\text{GSS}}$	-2.8	_	—	V	$I_{g} = -100 \mu A, V_{DS} = 0$
Gate to source leak current	I <sub>GSS1</sub>	—		100	μA	$V_{GS} = 8V, V_{DS} = 0$
	I <sub>GSS2</sub>	_		50	μΑ	$V_{GS} = 3.5V, V_{DS} = 0$
	I <sub>GSS3</sub>	—		1	μA	$V_{GS} = 1.2V, V_{DS} = 0$
	I <sub>GSS4</sub>	—	_	-100	μΑ	$V_{GS} = -2.4V, V_{DS} = 0$
Input current (shut down)	I <sub>GS(op)1</sub>	—	0.8	—	mA	$V_{GS} = 8V, V_{DS} = 0$
	I <sub>GS(op)2</sub>	—	0.35	_	mA	$V_{GS} = 3.5V, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>	—		250	μΑ	$V_{_{DS}} = 50 \text{ V}, V_{_{GS}} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	1.0		2.25	V	$I_{\rm D} = 1$ mA, $V_{\rm DS} = 10$ V
Static drain to source on state resistance	$R_{DS(on)}$	—	50	65	mΩ	$I_{\rm D}=10A,~V_{\rm GS}=4V^{\rm Note3}$
Static drain to source on state resistance	$R_{\text{DS(on)}}$	—	30	43	mΩ	$I_{D} = 10A, V_{GS} = 10V^{Note3}$
Forward transfer admittance	y <sub>fs</sub>	6	12	_	S	$I_{\rm D} = 10$ A, $V_{\rm DS} = 10V^{\rm Note3}$
Output capacitance	Coss	_	630	_	pF	$V_{\rm DS}=10V$ , $V_{\rm GS}=0$
						f = 1 MHz
Turn-on delay time	t <sub>d(on)</sub>	—	7.5	_	μs	$I_{\rm D} = 5A, V_{\rm GS} = 5V$
Rise time	t,	—	29	_	μs	$R_{L} = 6\Omega$
Turn-off delay time	t <sub>d(off)</sub>	—	34	_	μs	
Fall time	t <sub>f</sub>	_	26	_	μs	
Body-drain diode forward	$V_{\text{DF}}$	_	1.0		V	$I_{\rm F} = 20$ A, $V_{\rm GS} = 0$
voltage						
Body-drain diode reverse	t <sub>rr</sub>	_	110	_	ns	$I_{F} = 20A, V_{GS} = 0$
recovery time						diF/ dt =50A/µs
Over load shut down	t <sub>os1</sub>	_	1.8		ms	$V_{\rm GS}=5V,~V_{\rm DD}=12V$
operation time Note4	t <sub>os2</sub>	_	0.7		ms	$V_{GS} = 5V, V_{DD} = 24V$

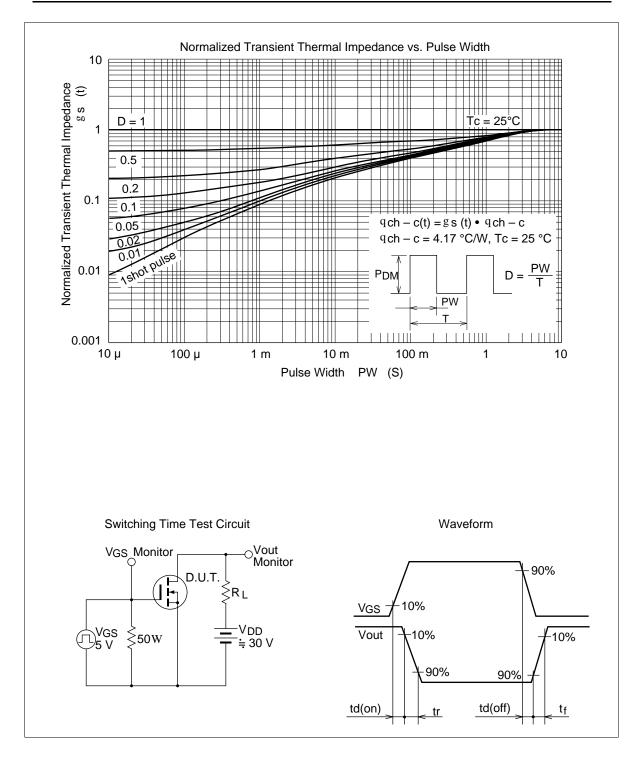
Note: 3. Pulse test

4. Include the time shift based on increasing of channel temperature when operate under over load condition.

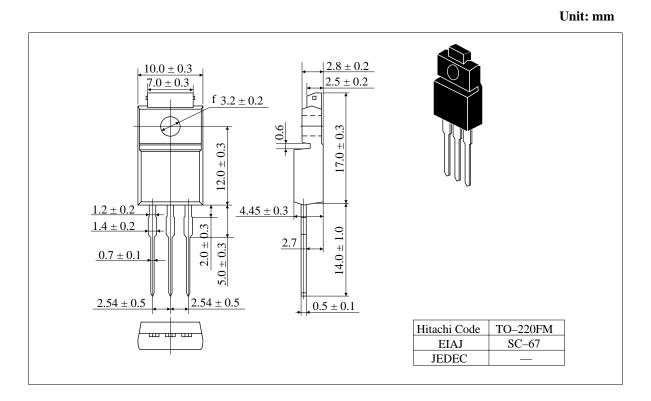
See characteristic curve of HAF2001.

#### **Main Characteristics**





# **Package Dimensions**



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